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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO
10/787,220	02/27/2004	Charles H. Skinner	S-103,712	4837
31970	7590 07/13/2005		EXAM	INER
	ATES DEPARTMENT	DEB, ANJAN K		
1000 INDEPENDENCE AVENUE, S.W. ATTN: GC-62 (CHI), MS 6F-067 WASHINGTON, DC 20585-0162			ART UNIT	PAPER NUMBER
			2858	

DATE MAILED: 07/13/2005

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)
	10/787,220	SKINNER, CHARLES H.
Office Action Summary	Examiner	Art Unit
	Anjan K. Deb	2858
The MAILING DATE of this communication a Period for Reply	appears on the cover sheet w	th the correspondence address
A SHORTENED STATUTORY PERIOD FOR REF THE MAILING DATE OF THIS COMMUNICATION - Extensions of time may be available under the provisions of 37 CFR after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a r - If NO period for reply is specified above, the maximum statutory perion - Failure to reply within the set or extended period for reply will, by state Any reply received by the Office later than three months after the materined patent term adjustment. See 37 CFR 1.704(b).	N. 1.136(a). In no event, however, may a reply within the statutory minimum of third will apply and will expire SIX (6) MON tute, cause the application to become AE	eply be timely filed y (30) days will be considered timely. THS from the mailing date of this communication. ANDONED (35 U.S.C. § 133).
Status		
1) Responsive to communication(s) filed on 27	February 2004	
·= · ·	his action is non-final.	
3) Since this application is in condition for allow	vance except for formal matt	ers, prosecution as to the merits is
closed in accordance with the practice unde	r <i>Ex parte</i> Q <i>uayle</i> , 1935 C.D	. 11, 453 O.G. 213.
Disposition of Claims		
4) ☐ Claim(s) 1-8 is/are pending in the application 4a) Of the above claim(s) is/are withd 5) ☐ Claim(s) is/are allowed. 6) ☐ Claim(s) 1-8 is/are rejected. 7) ☐ Claim(s) is/are objected to. 8) ☐ Claim(s) are subject to restriction and	rawn from consideration.	
Application Papers		
9) ☐ The specification is objected to by the Exami 10) ☑ The drawing(s) filed on 01 July 2004 is/are: Applicant may not request that any objection to the Replacement drawing sheet(s) including the corrulation. The oath or declaration is objected to by the	a)⊠ accepted or b)⊡ objecthe drawing(s) be held in abeyarthection is required if the drawing	nce. See 37 CFR 1.85(a). (s) is objected to. See 37 CFR 1.121(d).
Priority under 35 U.S.C. § 119		
12) Acknowledgment is made of a claim for forei a) All b) Some * c) None of: 1. Certified copies of the priority docume 2. Certified copies of the priority docume 3. Copies of the certified copies of the priority docume application from the International Bure * See the attached detailed Office action for a li	ents have been received. ents have been received in A riority documents have been eau (PCT Rule 17.2(a)).	pplication No received in this National Stage
Attachment(s) 1) ☑ Notice of References Cited (PTO-892)	4) 🗀 Interview 9	Summary (PTO-413)
2) Notice of Draftsperson's Patent Drawing Review (PTO-948)	Paper No(s)/Mail Date
3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/0 Paper No(s)/Mail Date	5) Notice of I 6) Other:	nformal Patent Application (PTO-152)

DETAILED ACTION

Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 2. Claim 1 is rejected under 35 U.S.C. 102(b) as being anticipated by Mori et al. (US 5,457,396 A).

Re claim 1, Mori et al. discloses apparatus for detecting dust (particle detecting) comprising an electrically conducting detection grid (electrode structure) having two or more interlocking tracing networks (1, 2) where each network has a plurality of tracing, where adjacent tracings have a specified separation or spacing and which in a dust free environment said grid represents an open circuit (pulse is generated only when particles (7,8) exist as shown in Fig. 3) (column 3 lines 18-20), an electrically nonconducting substrate (6) which supports said grid, a power supply (4) which is electrically coupled to said grid, a means (5) for detecting electrical changes (pulse) (Fig. 4) across said grid.

Claim Rejections - 35 USC § 103

- 3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person

Art Unit: 2858

having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

4. Claims 2-8 are rejected under 35 U.S.C. 103(a) as being unpatentable over Mori et al. (US 5,457,396 A) in view of Mehta (US 6,122,599 A).

Re claims 2-4, Mori et al. discloses all of the claimed limitations except electrical change detection means includes a means for filtering a signal generated by electrical change across said grid and a processing means including oscilloscope.

Mehta discloses method of measuring particles which includes a bandpass filter means for filtering a signal generated so as to select a range of frequencies of the pulse generated by the particle (column 11, lines 56-58) and processor (computer (210)) for processing output signals (Fig. 18).

At the time of the invention it would have been obvious for one of ordinary skill in the art to modify Mori et al. by adding bandpass filter means disclosed by Mehta so as to select a range of frequencies of the pulse generated by the particle.

Re claim 5, Mori et al. discloses counter for counting pulses (Fig. 5).

Re claim 6, Mori et al. and Mehta combined did not explicitly disclose an oscilloscope but would have been obvious for displaying the pulse generating frequency plot as shown in Fig. 4 disclosed by Mori et al.

Art Unit: 2858

At the time of the invention it would have been obvious for one of ordinary skill in the art to modify Mori et al. and Mehta by adding an oscilloscope for displaying pulse generating frequency plot.

Re claim 7, Mori et al. did not explicitly disclose power supply is capable of providing a variable bias voltage across a plurality of traces which form said grid.

Mehta disclosed switching logic 219 coupled to multiplexer 241 capable of applying variable bias voltage across a plurality of traces (array of planar electrodes)(column 12 lines 35-37)(Fig. 18)

At the time of the invention it would have been obvious for one of ordinary skill in the art to modify Mori et al. by adding a power supply capable of applying variable bias voltage across a plurality of traces as disclosed by Mehta for increasing particle measurement resolution.

Re claim 8, Mori et al. and Mehta combined did not explicitly disclose that the specified separation or spacing is determined based on the expected dust particle size, but would have been obvious since Mori et al. disclosed a range of spacing 1-50 µm that would be required to accommodate various sizes of particle.

At the time of the invention it would have been obvious for one of ordinary skill in the art to modify Mori et al. and Mehta by adding specified spacing between electrodes as required for detecting particles within a certain range of sizes.

Conclusion

5. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

Balousek (US 5,565,786 A) discloses particle detection apparatus comprising electrically conducting detection grid having two or more interlocking tracing networks (t1, t2) where each network has a plurality of tracings (C, C') supported on insulating substrate (Fig. 3).

Cheiky-Zelina (US 6,204,656 B1) discloses sensor for detection of particles comprising electrically conducting detection grid (10) having two or more interlocking tracing networks (14, 16) where each network has a plurality of tracings supported on insulating substrate (Fig. 1, 2A).

Frazier (US 6,169,394 A) discloses electrical detector for micro-analysis (broadly interpreted as detecting dust particles) systems comprising application of variable voltage to electrode and teaches that the signal-to-noise ratio grows directly with the applied voltage.

Frosch (US 4,338,568 A) discloses method of detection of particles using grid 30 having plurality of tracings (Fig. 2).

Application/Control Number: 10/787,220

Art Unit: 2858

Contact Information

Page 6

6. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Dr. Anjan K. Deb whose telephone number is 571-272-2228. If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Lefkowitz Edwards can be reached at 571-272-2180.

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Art Unit: 2858

7/7/05